## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | 10/611,314 | PEKAREK ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	α					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	C	Kim et al. 'Full Software Analysis and Impedance Matching of Radio Frequency CMOS Integrated Circuits'. Volume 23, March 2000. pages 183-189			
	٧	Lathi, B.P. 'Linear Systems and Signals'. Berkely-Cambridge Press, 1992. pages 278-284.			
	w				
	x				

<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.